

Notice of References Cited	Application/Control No. 10/085,409	Applicant(s)/Patent Under Reexamination SUN, HUNG-MING	
	Examiner Manav Seth	Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,450,647	09-2002	Takeuchi, Kesatoshi	353/69
	B	US-6,361,171	03-2002	Ejiri et al.	353/69
	C	US-6,520,647	02-2003	Raskar, Ramesh	353/70
	D	US-6,324,297	11-2001	Uchida, Kaoru	382/125
	E	US-6,791,616	09-2004	Tamaki et al.	348/335
	F	US-5,726,716	03-1998	Egashira et al.	348/580
	G	US-5,933,132	08-1999	Marshall et al.	345/158
	H	US-6,511,185	01-2003	Gananathan, Ravi K.	353/69
	I	US-5,528,194	06-1996	Ohtani et al.	382/293
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kannappan, IEEE Publication, 1992, " An interleaved scanline algorithm for 2-D affine transformations of images". (pp. 179-182)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.